佳恩半导体
JIAENSEMI

N-沟道功率 MOS 管　　JFUX5N50D(TO-251)/JFDX5N50D(TO-252)

●特点：导通电阻低　开关速度快　输入阻抗高　符合RoHS规范

●**FEATURES:** ■LOW ON-RESISTANCE ■FAST SWITCHING ■HIGH INPUT RESISTANCE ■RoHS COMPLIANT

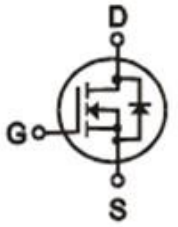
●应用：电子镇流器　电子变压器　开关电源

●**APPLICATION:** ■ELECTRONIC BALLAST■ELECTRONIC TRANSFORMER■SWITCH MODE POWER SUPPLY

●最大额定值（Tc=25°C）

●Absolute Maximum Ratings（Tc=25°C）　TO-251//252

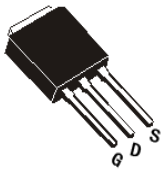
参数 PARAMETER	符号 SYMBOL	额定值 VALUE	单位 UNIT
漏-源电压 Drain-source Voltage	V_{DS}	500	V
栅-源电压 gate-source Voltage	V_{GS}	±30	V
漏极电流 Continuous Drain Current TC=25℃	I_D	5.0*	A
漏极电流 Continuous Drain Current TC=100℃	I_D	3.0*	A
最大脉冲电流 Drain Current －Pulsed ①	I_{DM}	20*	A
耗散功率 Power Dissipation	P_{tot}	50	W
最高结温 Junction Temperature	Tj	150	°C
存储温度 Storage Temperature	T_{STG}	-55-150	°C
单脉冲雪崩能量 Single Pulse Avalanche Energy ②	E_{AS}	280	mJ



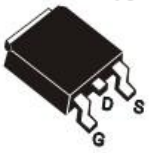
V_{DS}=500V

$R_{DS(ON)}$=1.5Ω

I_D=5.0A



TO-251



TO-252

*漏极电流由最高结温限制

*Drain current limited by maximum junction temperature

●电特性（Tc=25°C）

●Electronic Characteristics（Tc=25°C）

参数 PARAMETER	符号 SYMBOL	测试条件 TEST CONDITION	最小值 MIN	典型值 TYP	最大值 MAX	单位 UNIT
漏-源击穿电压 Drain-source Breakdown Voltage	BV_{DSS}	V_{GS}=0V, I_D=250μA	500			V
击穿电压温度系数 Breakdown Voltage Temperature Coefficient	$\Delta BV_{DSS}/\Delta Tj$	I_D=250uA, Referenced to 25°C		0.6		V/°C
栅极开启电压 Gate Threshold Voltage	$V_{GS(TH)}$	V_{GS}=V_{DS}, I_D=250μA	2.0		4.0	V
漏-源漏电流 Drain-source Leakage Current	I_{DSS}	V_{DS} =500V, V_{GS} =0V, Tj=25°C			25	μA
		V_{DS} =400V, V_{GS} =0V, Tj=125°C			250	μA
跨导 Forward Transconductance	gfs	V_{DS} =15V, I_D=2.5A ③	2.4			S

N-沟道功率 MOS 管　　JFUX5N50D(TO-251)/JFDX5N50D(TO-252)

参数 PARAMETER	符号 SYMBOL	测试条件 TEST CONDITION	最小值 MIN	典型值 TYP	最大值 MAX	单位 UNIT
栅极漏电流 Gate-body Leakage Current (V_{DS} = 0)	I_{GSS}	V_{GS} =±30V			±100	nA
漏-源导通电阻 Static Drain-source On Resistance	$R_{DS(ON)}$	V_{GS} =10V, I_D=2.5A ③		1.35	1.5	Ω
输入电容 Input Capacitance	Ciss	V_{GS} = 0V, V_{DS} = 25V F = 1.0MHZ		580		pF
输出电容 Output Capacitance	Coss			45		
反馈电容 Feedback Capacitance	Crss			17		
关断延迟 Turn -Off Delay Time	Td(off)	V_{DD}=300V, I_D =4.0A R_G=25Ω ③		20		ns
栅极电荷 Total Gate Charge	Qg	I_D =5.0A, V_{DS} = 480V V_{GS} = 10V ③		26		nC
栅源电荷 Gate-to-Source Charge	Qgs			4		nC
栅漏电荷 Gate-to-Drain Charge	Qgd			15		nC
二极管正向电流 Continuous Diode Forward Current	I_S				5.0	A
二极管正向压降 Diode Forward Voltage	V_{SD}	Tj=25°C, Is=5.0A V_{GS} =0V ③			1.6	V
反向恢复时间 Reverse Recovery Time	trr	Tj=25°C, If=5.0A di/dt=100A/μs ③		220		ns
反向恢复电荷 Reverse Recovery Charge	Qrr			1.0		uC

●热特性

●Thermal Characteristics

参数 PARAMETER	符号 SYMBOL	最大值 MAX	单位 UNIT
热阻结-壳 Thermal Resistance Junction-case	Rth_{JC}	2.50	℃/W
热阻结-环境 Thermal Resistance Junction-ambient	Rth_{JA}	110.0	℃/W

注释(Notes):

① 脉冲宽度：以最高结温为限制

Repetitive rating: Pulse width limited by maximum junction temperature

② 初始结温=25ºC, V_{DD} =50V, L=24mH, R_G =25Ω, I_{AS}=5.0A

Starting Tj=25ºC, V_{DD} =50V, L=24mH, R_G =25Ω, I_{AS}=5.0A

③ 脉冲测试：脉冲宽度≤ 300μs ， 占空比≤ 2 %

Pulse Test : Pulse width ≤ 300μs, Duty cycle ≤ 2%

● 特性曲线

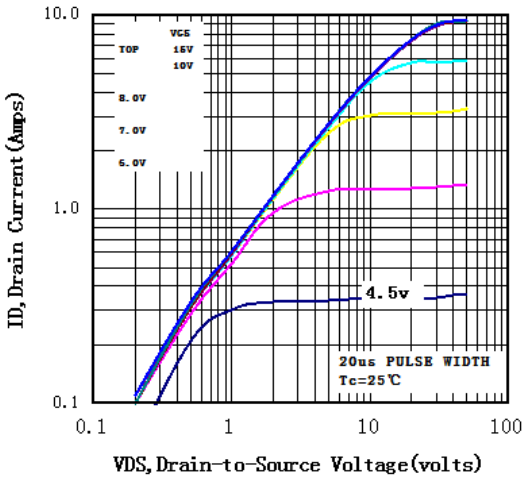


图 1 输出特性曲线, Tc=25℃

Fig1 Typical Output Characteristics, Tc=25℃

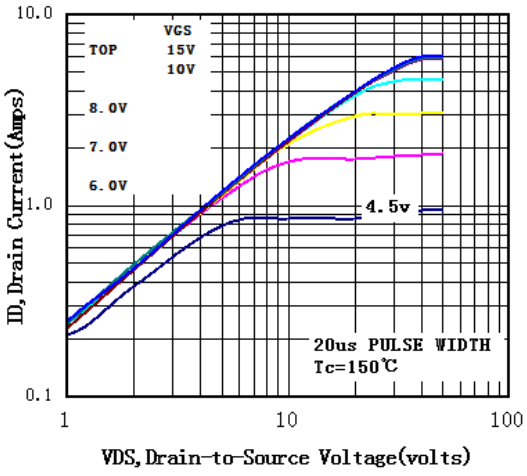


图 2 输出特性曲线, Tc=150℃

Fig2 Typical Output Characteristics, Tc=150℃

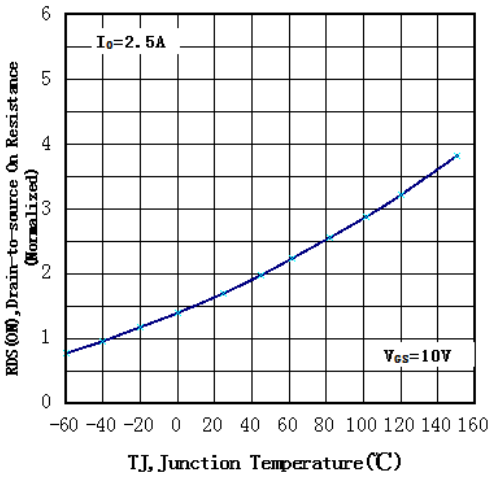


图 3 归一化导通电阻与温度曲线

Fig3 Normalized Resistance Vs.Temperature

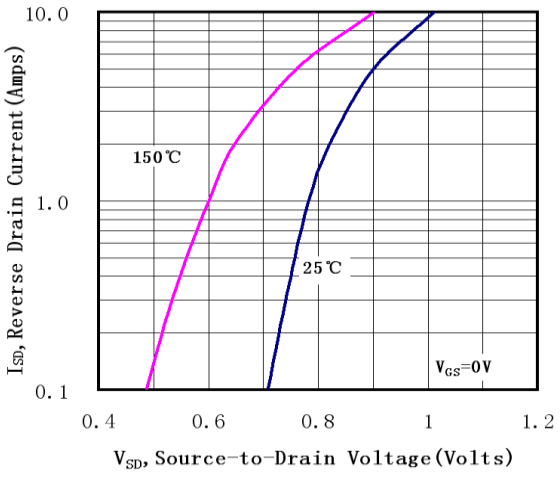


图 4 二极管正向电压曲线

Fig4 Typical Source-Drain Diode Forward Voltage

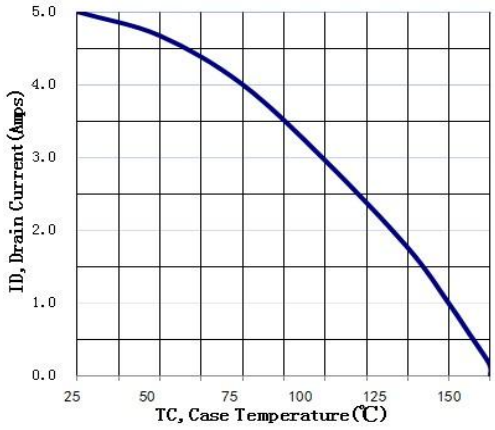


图 5 最大漏极电流与壳温曲线

Fig5 Maximum Drain Current Vs.Case Temperature

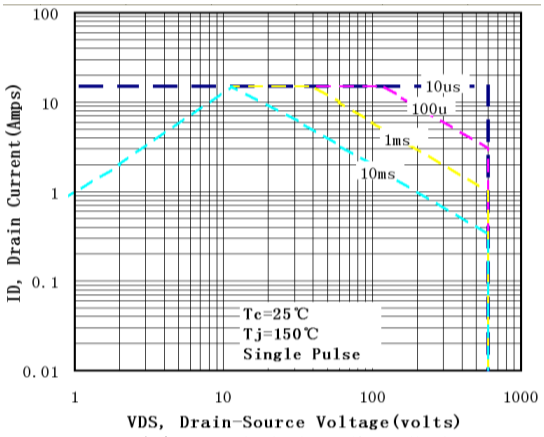


图 6 最大安全工作区曲线

Fig6 Maximum Safe Operating Area